

Application/Control No.	Applicant(s)/Patent under Reexamination
09/967,084	BEIER ET AL.
Examiner	Art Unit
Michael Y. Won	2155

SEARCHED						
Class	Subclass	Date	Examiner			
711	3, 118, 147, 213, 216, 221	7/14/2006	MW			
707	205	7/14/2006	MW			
709	212, 214	7/14/2006	MW			
709	215, 245	7/14/2006	MW			
			,,			

INT	ERFERENC	E SEARCHI	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	7/14/2006	MW		
	·			